Buffers with open-drain outputs Rev. 1 — 15 November 2013

Product data sheet

#### **General description** 1.

The 74LVC2G07-Q100 provides two non-inverting buffers.

The output of this device is an open drain and can be connected to other open-drain outputs to implement active-LOW wired-OR or active-HIGH wired-AND functions.

Inputs can be driven from either 3.3 V or 5 V devices. This feature allows the use of this device in a mixed 3.3 V and 5 V environment.

Schmitt trigger action at all inputs makes the circuit tolerant for slower input rise and fall time.

This device is fully specified for partial power-down applications using I<sub>OFF</sub>. The I<sub>OFF</sub> circuitry disables the output, preventing the damaging backflow current through the device when it is powered down.

This product has been gualified to the Automotive Electronics Council (AEC) standard Q100 (Grade 1) and is suitable for use in automotive applications.

#### 2. **Features and benefits**

- Automotive product qualification in accordance with AEC-Q100 (Grade 1)
  - Specified from –40 °C to +85 °C and from –40 °C to +125 °C
- Wide supply voltage range from 1.65 V to 5.5 V
- 5 V tolerant input/output for interfacing with 5 V logic
- High noise immunity
- Complies with JEDEC standard:
  - JESD8-7 (1.65 V to 1.95 V)
  - JESD8-5 (2.3 V to 2.7 V)
  - JESD8-B/JESD36 (2.7 V to 3.6 V)
- -24 mA output drive (V<sub>CC</sub> = 3.0 V)
- CMOS low power consumption
- Latch-up performance exceeds 250 mA
- Direct interface with TTL levels
- Inputs accept voltages up to 5 V
- Multiple package options
- ESD protection:
  - MIL-STD-883, method 3015 exceeds 2000 V
  - HBM JESD22-A114F exceeds 2000 V
  - MM JESD22-A115-A exceeds 200 V (C = 200 pf, R = 0 Ω)



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## 3. Ordering information

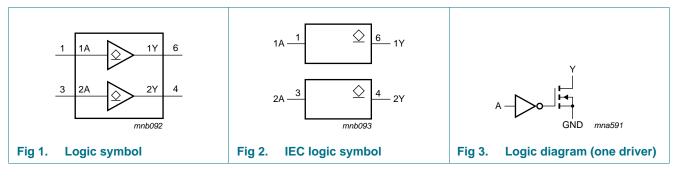
Table 1. Ordering in	nformation			
Type number	Package			
	Temperature range	Name	Description	Version
74LVC2G07GW-Q100	–40 °C to +125 °C	SC-88	plastic surface-mounted package; 6 leads	SOT363
74LVC2G07GV-Q100	–40 °C to +125 °C	TSOP6	plastic surface-mounted package (TSOP6); 6 leads	SOT457

## 4. Marking

Table 2. Marking	
Type number	Marking code <sup>[1]</sup>
74LVC2G07GW-Q100	V7
74LVC2G07GV-Q100	V07

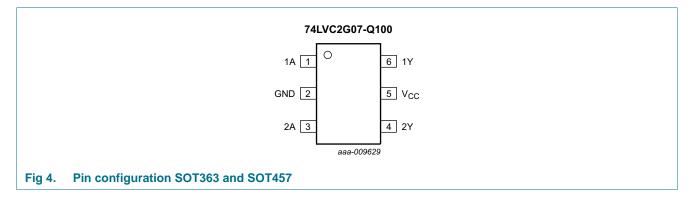
[1] The pin 1 indicator is located on the lower left corner of the device, below the marking code.

## 5. Functional diagram



## 6. Pinning information

### 6.1 Pinning



### 6.2 Pin description

Table 3.	Pin description	
Symbol	Pin	Description
1A	1	data input
GND	2	ground (0 V)
2A	3	data input
2Y	4	data output
V <sub>CC</sub>	5	supply voltage
1Y	6	data output

## 7. Functional description

#### Table 4. Function table<sup>[1]</sup>

Input nA	Output nY
L	L
Н	Z

[1] H = HIGH voltage level; L = LOW voltage level; Z = high-impedance OFF-state.

### 8. Limiting values

#### Table 5.Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

					-
Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>CC</sub>	supply voltage		-0.5	+6.5	V
I <sub>IK</sub>	input clamping current	V <sub>I</sub> < 0 V	-50	-	mA
VI	input voltage		<u>[1]</u> –0.5	+6.5	V
I <sub>OK</sub>	output clamping current	V <sub>O</sub> < 0 V	-50	-	mA
Vo	output voltage	Active mode	<u>[1]</u> –0.5	+6.5	V
		Power-down mode	<u>[1][2]</u> –0.5	+6.5	V
lo	output current	$V_{O} = 0 V$ to 6.5 V	-	50	mA
I <sub>CC</sub>	supply current		-	100	mA
I <sub>GND</sub>	ground current		-100	-	mA
T <sub>stg</sub>	storage temperature		-65	+150	°C
P <sub>tot</sub>	total power dissipation	$T_{amb} = -40 \ ^{\circ}C \ to \ +125 \ ^{\circ}C$	[3] _	250	mW

[1] The minimum input and output voltage ratings may be exceeded if the input and output current ratings are observed.

[2] When  $V_{CC} = 0 V$  (Power-down mode), the output voltage can be 5.5 V in normal operation.

[3] For SC-88 and TSOP6 packages: above 87.5 °C the value of Ptot derates linearly with 4.0 mW/K.

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## 9. Recommended operating conditions

Table 6.	Recommended operating conditions					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V <sub>CC</sub>	supply voltage		1.65	-	5.5	V
VI	input voltage		0	-	5.5	V
Vo	output voltage	Active mode	0	-	5.5	V
		Power-down mode; $V_{CC} = 0 V$	0	-	5.5	V
T <sub>amb</sub>	ambient temperature		-40	-	+125	°C
$\Delta t / \Delta V$	input transition rise and fall rate	$V_{CC}$ = 1.65 V to 2.7 V	-	-	20	ns/V
		$V_{CC}$ = 2.7 V to 5.5 V	-	-	10	ns/V

## **10. Static characteristics**

### Table 7. Static characteristics

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
T <sub>amb</sub> = -40	) °C to +85 °C <u>[1]</u>					
V <sub>IH</sub>	HIGH-level input	$V_{CC}$ = 1.65 V to 1.95 V	$0.65 \times V_{CC}$	-	-	V
	voltage	$V_{CC}$ = 2.3 V to 2.7 V	1.7	-	-	V
		$V_{CC} = 2.7 V \text{ to } 3.6 V$	2.0	-	-	V
		$V_{CC}$ = 4.5 V to 5.5 V	$0.7\times V_{CC}$	-	-	V
V <sub>IL</sub> LOW-level input		$V_{CC}$ = 1.65 V to 1.95 V	-	-	$0.35\times V_{CC}$	V
	voltage	$V_{CC}$ = 2.3 V to 2.7 V	-	-	0.7	V
		$V_{CC}$ = 2.7 V to 3.6 V	-	-	0.8	V
		$V_{CC}$ = 4.5 V to 5.5 V	-	-	$0.3\times V_{CC}$	V
V <sub>OL</sub> LOW-level output		$V_I = V_{IH} \text{ or } V_{IL}$				
vol	voltage	$I_{O}$ = 100 $\mu\text{A};$ $V_{CC}$ = 1.65 V to 5.5 V	-	-	0.10	V
		$I_0 = 4 \text{ mA}; V_{CC} = 1.65 \text{ V}$	-	-	0.45	V
		$I_0 = 8 \text{ mA}; V_{CC} = 2.3 \text{ V}$	-	-	0.30	V
		$I_0 = 12 \text{ mA}; V_{CC} = 2.7 \text{ V}$	-	-	0.40	V
		$I_{O} = 24 \text{ mA}; V_{CC} = 3.0 \text{ V}$	-	-	0.55	V
		$I_{O} = 32 \text{ mA}; V_{CC} = 4.5 \text{ V}$	-	-	0.55	V
I	input leakage current	V <sub>I</sub> = 5.5 V or GND; V <sub>CC</sub> = 0 V to 5.5 V	[2] _	±0.1	±5	μA
I <sub>OZ</sub>	OFF-state output current		-	±0.1	±10	μΑ
OFF	power-off leakage current	$V_{I}$ or $V_{O}$ = 5.5 V; $V_{CC}$ = 0 V	-	±0.1	±10	μΑ
lcc	supply current	$V_{I} = 5.5 V \text{ or GND}; I_{O} = 0 \text{ A};$ $V_{CC} = 1.65 V \text{ to } 5.5 V$	-	0.1	10	μΑ
∆I <sub>CC</sub>	additional supply current	per pin; V <sub>I</sub> = V <sub>CC</sub> – 0.6 V; I <sub>O</sub> = 0 A; V <sub>CC</sub> = 2.3 V to 5.5 V	[2] _	5	500	μΑ
CI	input capacitance		-	2.5	-	pF

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Symbol	Parameter	Conditions	Min	Тур	Max	Unit
T <sub>amb</sub> = -40	°C to +125 °C					
VIH	HIGH-level input	V <sub>CC</sub> = 1.65 V to 1.95 V	$0.65 \times V_{CC}$	-	-	V
	voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	1.7	-	-	V
		$V_{CC} = 2.7 V \text{ to } 3.6 V$	2.0	-	-	V
		$V_{CC} = 4.5 V \text{ to } 5.5 V$	$0.7\times V_{CC}$	-	-	V
V <sub>IL</sub>	LOW-level input	V <sub>CC</sub> = 1.65 V to 1.95 V	-	-	$0.35\times V_{CC}$	V
	voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	-	-	0.7	V
		$V_{CC} = 2.7 V \text{ to } 3.6 V$	-	-	0.8	V
		$V_{CC} = 4.5 V \text{ to } 5.5 V$	-	-	$0.3\times V_{CC}$	V
02	LOW-level output voltage	$V_{I} = V_{IH} \text{ or } V_{IL}$				
		$I_0 = 100 \ \mu\text{A}; \ V_{CC} = 1.65 \ \text{V} \text{ to } 5.5 \ \text{V}$	-	-	0.10	V
		I <sub>O</sub> = 4 mA; V <sub>CC</sub> = 1.65 V	-	-	0.70	V
		$I_0 = 8 \text{ mA}; V_{CC} = 2.3 \text{ V}$	-	-	0.45	V
		$I_0 = 12 \text{ mA}; V_{CC} = 2.7 \text{ V}$	-	-	0.60	V
		$I_0 = 24 \text{ mA}; V_{CC} = 3.0 \text{ V}$	-	-	0.80	V
		$I_0 = 32 \text{ mA}; V_{CC} = 4.5 \text{ V}$	-	-	0.80	V
I	input leakage current	V <sub>I</sub> = 5.5 V or GND; V <sub>CC</sub> = 0 V to 5.5 V	-	-	±20	μΑ
I <sub>OZ</sub>	OFF-state output current		-	-	±10	μΑ
I <sub>OFF</sub>	power-off leakage current	$V_{\rm I}$ or $V_{\rm O}$ = 5.5 V; $V_{\rm CC}$ = 0 V	-	-	±20	μΑ
lcc	supply current	$V_{I} = 5.5 V \text{ or GND}; I_{O} = 0 \text{ A};$ $V_{CC} = 1.65 V \text{ to } 5.5 V$	-	-	40	μA
Δl <sub>CC</sub>	additional supply current	per pin; V <sub>I</sub> = V <sub>CC</sub> - 0.6 V; I <sub>O</sub> = 0 A; V <sub>CC</sub> = 2.3 V to 5.5 V	-	-	5000	μA

#### Table 7. Static characteristics ...continued

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

[1] All typical values are measured at  $T_{amb}$  = 25 °C.

[2] These typical values are measured at  $V_{CC}$  = 3.3 V.

## **11. Dynamic characteristics**

#### Table 8. Dynamic characteristics

Voltages are referenced to GND (ground = 0 V); for test circuit, see Figure 6.

Symbol Parameter		Conditions		–40 °C to +85 °C			–40 °C to +125 °C		Unit
				Min	Typ <mark>[1]</mark>	Max	Min	Max	
t <sub>pd</sub>	propagation delay	nA to nY; see Figure 5	[2]						
	$V_{CC}$ = 1.65 V to 1.95 V		1.0	3.5	6.7	1.0	8.4	ns	
		$V_{CC}$ = 2.3 V to 2.7 V		0.5	2.4	4.3	0.5	5.5	ns
		$V_{CC} = 2.7 V$		1.0	2.3	4.2	1.0	5.3	ns
		$V_{CC} = 3.0 \text{ V} \text{ to } 3.6 \text{ V}$		0.5	2.6	3.7	0.5	4.7	ns
		$V_{CC}$ = 4.5 V to 5.5 V		0.5	1.5	2.9	0.5	3.7	ns
$C_{PD}$	power dissipation capacitance	$V_{\text{I}}$ = GND to $V_{\text{CC}};V_{\text{CC}}$ = 3.3 V	<u>[3]</u>	-	6.5	-	-	-	pF

[1] Typical values are measured at  $T_{amb}$  = 25 °C and  $V_{CC}$  = 1.8 V, 2.5 V, 2.7 V, 3.3 V and 5.0 V respectively.

 $\label{eq:tpd} [2] \quad t_{pd} \text{ is the same as } t_{PLZ} \text{ and } t_{PZL}.$ 

[3]  $C_{PD}$  is used to determine the dynamic power dissipation (P<sub>D</sub> in  $\mu$ W).

 $P_{D} = C_{PD} \times V_{CC}^{2} \times f_{i} \times N + \sum (C_{L} \times V_{CC}^{2} \times f_{o}) \text{ where:}$ 

 $f_i = input frequency in MHz;$ 

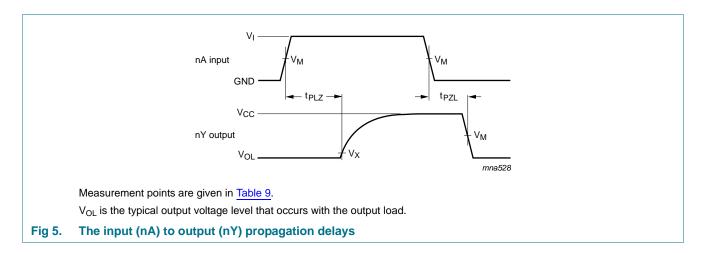
$$\label{eq:fo} \begin{split} &f_o = \text{output frequency in MHz;} \\ &C_L = \text{output load capacitance in pF;} \end{split}$$

 $V_{CC}$  = supply voltage in V;

N = number of inputs switching;

### $\sum (C_L \times V_{CC}^2 \times f_o) = \text{sum of outputs.}$

## 12. Waveforms



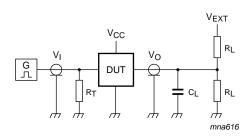
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Table 9. Measurement points					
Supply voltage	Input	Output			
V <sub>cc</sub>	V <sub>M</sub>	V <sub>M</sub>	V <sub>x</sub>		
1.65 V to 1.95 V	$0.5  imes V_{CC}$	$0.5\times V_{CC}$	V <sub>OL</sub> + 0.15 V		
2.3 V to 2.7 V	$0.5\times V_{CC}$	$0.5\times V_{CC}$	V <sub>OL</sub> + 0.15 V		
2.7 V	1.5 V	1.5 V	V <sub>OL</sub> + 0.3 V		
3.0 V to 3.6 V	1.5 V	1.5 V	V <sub>OL</sub> + 0.3 V		
4.5 V to 5.5 V	$0.5  imes V_{CC}$	$0.5\times V_{CC}$	V <sub>OL</sub> + 0.3 V		



Test data is given in Table 10.

Definitions for test circuit:

R<sub>L</sub> = Load resistance.

 $C_L$  = Load capacitance including jig and probe capacitance.

 $R_T$  = Termination resistance should be equal to the output impedance  $Z_0$  of the pulse generator.

 $V_{EXT}$  = External voltage for measuring switching times.

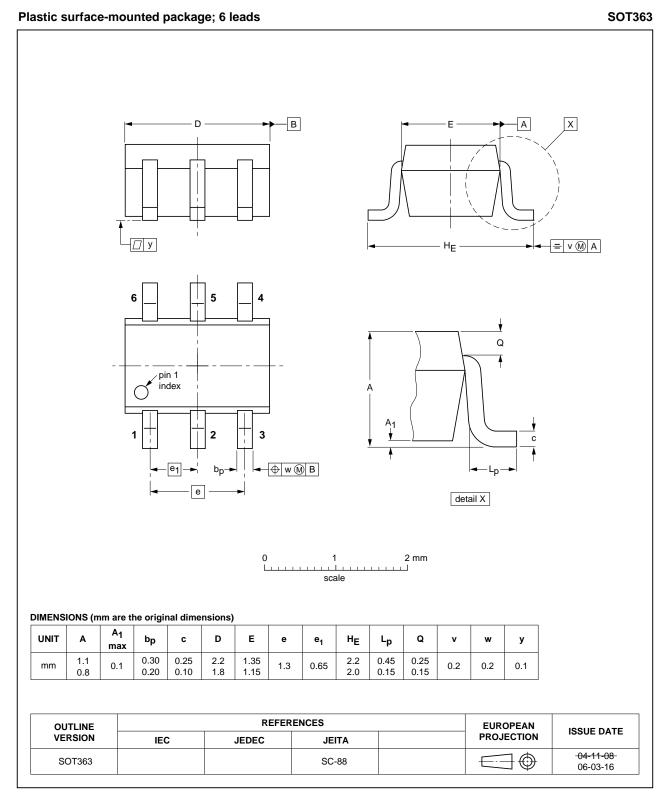
Fig 6. Test circuit for measuring switching times

#### Table 10. Test data

Supply voltage	Input		Load		V <sub>EXT</sub>
V <sub>CC</sub>	VI	t <sub>r</sub> , t <sub>f</sub>	CL	RL	t <sub>PZL</sub> , t <sub>PLZ</sub>
1.65 V to 1.95 V	V <sub>CC</sub>	$\leq$ 2.0 ns	30 pF	1 kΩ	$2 \times V_{CC}$
2.3 V to 2.7 V	V <sub>CC</sub>	$\leq$ 2.0 ns	30 pF	500 Ω	$2 \times V_{CC}$
2.7 V	2.7 V	$\leq$ 2.5 ns	50 pF	500 Ω	6 V
3.0 V to 3.6 V	2.7 V	$\leq$ 2.5 ns	50 pF	500 Ω	6 V
4.5 V to 5.5 V	V <sub>CC</sub>	$\leq$ 2.5 ns	50 pF	500 Ω	$2\times V_{CC}$

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## 13. Package outline



### Fig 7. Package outline SOT363 (SC-88)

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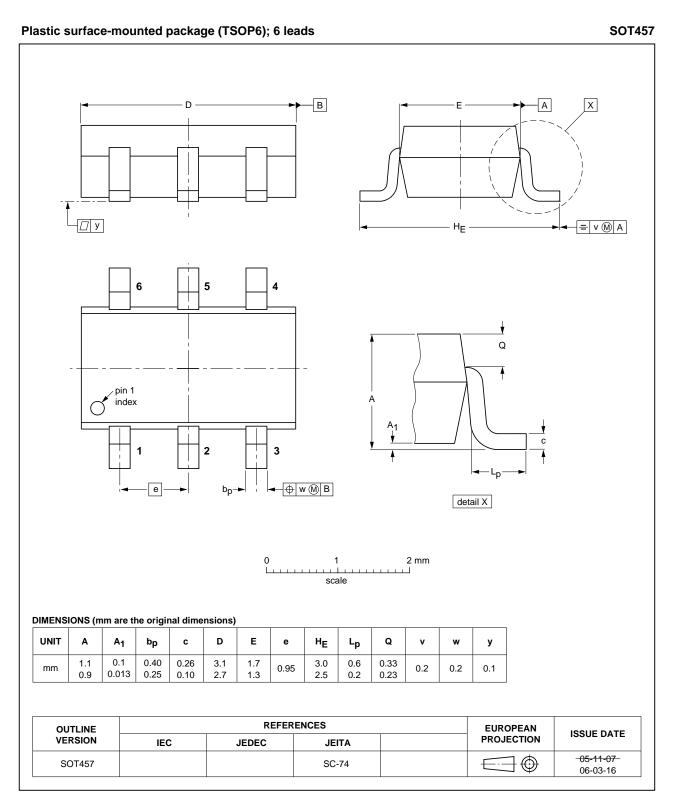


Fig 8. Package outline SOT457 (TSOP6)

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## 14. Abbreviations

AcronymDescriptionCMOSComplementary Metal Oxide SemiconductorDUTDevice Under TestESDElectroStatic DischargeHBMHuman Body ModelMILMilitaryMMMachine ModelTTLTransistor-Transistor Logic	Table 11.	Abbreviations
DUTDevice Under TestESDElectroStatic DischargeHBMHuman Body ModelMILMilitaryMMMachine Model	Acronym	Description
ESDElectroStatic DischargeHBMHuman Body ModelMILMilitaryMMMachine Model	CMOS	Complementary Metal Oxide Semiconductor
HBM     Human Body Model       MIL     Military       MM     Machine Model	DUT	Device Under Test
MIL     Military       MM     Machine Model	ESD	ElectroStatic Discharge
MM Machine Model	HBM	Human Body Model
	MIL	Military
TTL Transistor-Transistor Logic	MM	Machine Model
	TTL	Transistor-Transistor Logic

## **15. Revision history**

Table 12. Revision history					
Document ID	Release date	Data sheet status	Change notice	Supersedes	
74LVC2G07_Q100 v.1	20131115	Product data sheet	-	-	

## 16. Legal information

### 16.1 Data sheet status

Document status[1][2]	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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